

Title of Change:	KAF-16801 datasheet update: Correction of errors induced by incorrect copy/paste actions.	
Effective date:	2 February 2018	
Contact information:	Contact your local ON Semiconductor Sales Office or < <u>John.Frenett@onsemi.com</u> >	
Type of notification:	This Product Bulletin is for notification purposes only. ON Semiconductor will proceed with implementation of this change upon publication of this Product Bulletin.	
Change category:	Wafer Fab Change Assembly Change	Test Change X Other <u>Documentation</u>
Manufacturing Site Change/Addition Material Change Shange Shange		<ul> <li>Datasheet/Product Doc change</li> <li>Shipping/Packaging/Marking</li> <li>Other:</li></ul>
Sites Affected:	ON Semiconductor Sites: ON Rochester, New York	External Foundry/Subcon Sites: None
Description and Purpose:		
<ol> <li>Table 9 (CLOCK LEVELS) has been updated, as follows:         <ul> <li>Nominal value for Horizontal CCD Clock – Phase 1 was 2.0 V; now reads 8.0 V</li> <li>Nominal value for Horizontal CCD Clock – Phase 2 was 2.0 V; now reads 8.0 V</li> </ul> </li> <li>The change will not impact form, fit, or function of KAF-16801 image sensors.</li> </ol>		
List of Affected Standard Parts:		
KAF-16801-AAA-DP-AE KAF-16801-AAA-DP-B1 KAF-16801-AAA-DP-B2		

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Product	Customer Part Number
KAF-16801-AAA-DP-B1	
KAF-16801-AAA-DP-B2	